

Notice of References Cited		Application/Control No. 08/796,519	Applicant(s)/Patent Under Reexamination INOUE ET AL.	
		Examiner LAM S. NGUYEN	Art Unit 2853	Page 1 of 1

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-5,552,816	09-1996	Oda et al.	347/86
B	US-			
C	US-			
D	US-			
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

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*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N	EP 546 832 A2	06-1993	EP	Wada et al.	--/--
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R					
S					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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